

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/763,733	MCELHENY, PETER JOH	N	
Examiner	Art Unit		
Phallaka Kik	2825		

SEARCHED					
Class	Subclass	Date	Examiner		
716	16,18,2,7	12/23/2005	PK		
Above	updated	2/18/2006	PK		
Above	updated	3/22/2006	PK		
Above	updated	5/23/2006	PK		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
716	16,18,2,7	5/23/2006	PK	
-USPGPUB (see attached)		5/23/2006	PK	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
BRS (EAST)USPAT, USPGPUB Class/sub searched: 716/1-18 (see attached)	12/23/2005	PK		
Above updated search (see attached)	2/18/2006	PK		
Above updated search (see attached)	3/22/2006	PK		
Above updated search (see attached)	5/23/2006	PK		
EPO, JPO, IBM TDB, Derwent (see attached)	12/23/2005	PK		
IEE/IEEE Xplore (see attached)	12/23/2005	PK		
New Search Cls/sub searched: 713/1,2,100 (see attached)	5/23/2006	PK		